



<p>Searched</p> 	<p>Application/Control No.</p> <p>10754009</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>MATSUBARA ET AL.</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
307	10.4	07/27/2006	HK
307	10.5	07/27/2006	HK
123	179.2	07/27/2006	HK
340	426.11	07/27/2006	HK
340	426.12	07/27/2006	HK
340	426.13	07/27/2006	HK
340	426.16	07/27/2006	HK
340	426.17	07/27/2006	HK

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Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10754009	MATSUBARA ET AL.
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Notes	Date	Examiner
EAST (US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	07/27/2006	HK
EAST (US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	07/28/2006	HK
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